Silicon N-Channel MOS FET



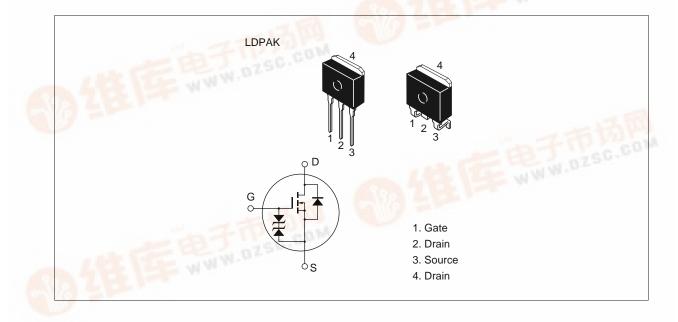
Application

High speed power switching

Features

- Low on-resistance
- High speed switching
- Low drive current
- No secondary breakdown
- Suitable for switching regulator, DC-DC converter and motor driver

Outline





Absolute Maximum Ratings ($Ta = 25^{\circ}C$)

Item		Symbol	Ratings	Unit
Drain to source voltage	2SK1315	V _{DSS}	450	V
	2SK1316		500	
Gate to source voltage		V _{GSS}	±30	V
Drain current		I _D	8	А
Drain peak current		L _{D(pulse)} *1	32	А
Body to drain diode reverse drain current		I _{DR}	8	А
Channel dissipation		Pch*2	60	W
Channel temperature		Tch	150	°C
Storage temperature		Tstg	-55 to +150	٥C

Notes: 1. $PW \le 10 \ \mu s$, duty cycle $\le 1\%$

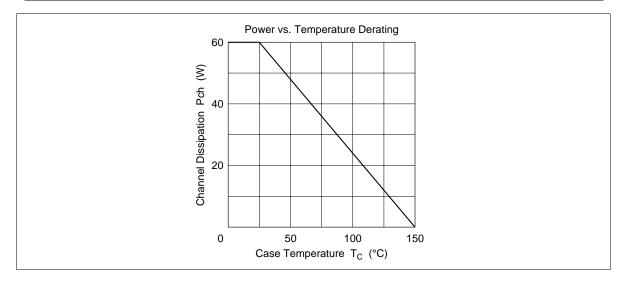
2. Value at $T_c = 25^{\circ}C$

Electrical Characteristics (Ta = 25°C)

Item		Symbol	Min	Тур	Мах	Unit	Test conditions
Drain to source	2SK1315	$V_{(BR)DSS}$	450	_	_	V	$I_{\rm D} = 10 \text{ mA}, V_{\rm GS} = 0$
breakdown voltage	2SK1316	-	500	_			
Gate to source breako voltage	down	$V_{(BR)GSS}$	±30	—	_	V	$I_{g} = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak cu	urrent	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 25 \text{ V}, \text{ V}_{DS} = 0$
Zero gate voltage	2SK1315	I _{DSS}	_	_	250	μA	$V_{\rm DS} = 360$ V, $V_{\rm GS} = 0$
drain current	2SK1316	-					$V_{\rm DS} = 400$ V, $V_{\rm GS} = 0$
Gate to source cutoff	voltage	$V_{\text{GS(off)}}$	2.0		3.0	V	$I_{\rm D} = 1 \text{ mA}, V_{\rm DS} = 10 \text{ V}$
Static Drain to source	2SK1315	$R_{DS(on)}$	_	0.55	0.7	Ω	$I_{\rm D} = 4$ A, $V_{\rm GS} = 10$ V * ¹
on state resistance	2SK1316		_	0.60	0.8	-	
Forward transfer admi	ittance	yfs	4.5	7.5	_	S	$I_{\rm D} = 4$ A, $V_{\rm DS} = 10$ V *1
Input capacitance		Ciss	—	1150	_	pF	$V_{\rm DS} = 10 \ V, \ V_{\rm GS} = 0,$
Output capacitance		Coss	—	340	—	pF	f = 1 MHz
Reverse transfer capacitance		Crss	_	55	_	pF	-
Turn-on delay time		t _{d(on)}	—	17	_	ns	$I_{\rm D} = 4 \text{ A}, V_{\rm GS} = 10 \text{ V},$
Rise time		t,	—	55	_	ns	$R_{L} = 7.5 \Omega$
Turn-off delay time		t _{d(off)}	_	100	_	ns	-
Fall time		t _f	—	45	—	ns	-
Body to drain diode fo voltage	orward	V_{DF}	—	0.9	_	V	$I_{F} = 8 \text{ A}, V_{GS} = 0$
Body to drain diode re recovery time	everse	t _{rr}	—	350	_	ns	$I_{F} = 8 \text{ A}, V_{GS} = 0,$ $di_{F}/dt = 100 \text{ A}/\mu\text{s}$

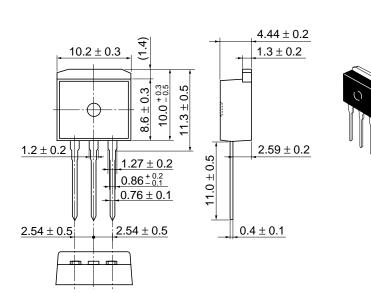
Note: 1. Pulse test

See characteristic curves of 2SK1159, 2SK1160.



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